Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/567,602	NAKAGAWA ET AL.	
Examiner	Art Unit	
TUAN A. PHAM	2618	

TUAN A. PHAM

SEARCHED			
Class	Subclass	Date	Examiner
455	Update search	11/10/2007	PHAM

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEAR (INCLUDING SI	CH NOTES EARCH STRATEG	SY)
	DATE	EXMR
Consulted with: Nguyen Vo	11/12/200	7 PHAM